

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/501,165	ANTON APETZ ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Hana A. Sanei	2879	

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*	B	US-6,025,065	02-2000	Claussen et al.	428/307.7
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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